

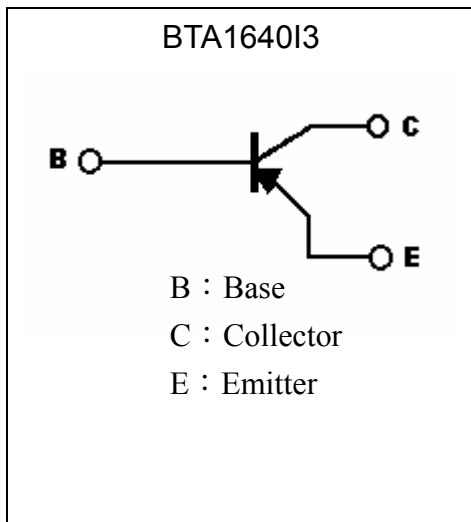
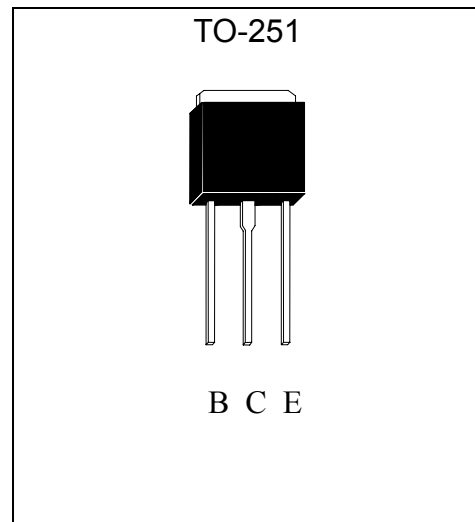
PNP Epitaxial Planar Power Transistor

BTA1640I3

V_{CEO}	-50V
I_C	-7A
R_{CESAT}	70m Ω

Features

- Low collector-emitter saturation voltage, $V_{CE(sat)} = -0.4V(max) @ I_C = -3A, I_B = -0.15A$
- Excellent current gain linearity
- RoHS compliant package

Symbol

Outline

Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Limits	Unit
Collector-Base Voltage	V_{CBO}	-60	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current (DC)	I_C	-7	A
Collector Current (Pulse)	I_{CP}	-10 (Note 1)	
Power Dissipation @ $T_A=25^\circ C$	P_D	1	W
Power Dissipation @ $T_C=25^\circ C$	P_D	20	
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	125	$^\circ C/W$
Thermal Resistance, Junction to Case	$R_{\theta JC}$	6.25	$^\circ C/W$
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55~+150	$^\circ C$

Note : 1. Single Pulse , $P_w \leq 380\mu s$, Duty $\leq 2\%$.



Characteristics (Ta=25°C)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
*BV _{CEO}	-50	-	-	V	I _C =-10mA, I _B =0
BV _{CBO}	-60	-	-	V	I _C =-1mA, I _E =0
BV _{EBO}	-5	-	-	V	I _E =-1mA, I _C =0
I _{CEO}	-	-	-50	μA	V _{CE} =-30V, I _B =0
I _{CBO}	-	-	-1	μA	V _{CB} =-50V, I _B =0
I _{EBO}	-	-	-1	μA	V _{EB} =-5V, I _C =0
*V _{CE(sat)}	-	-0.2	-0.4	V	I _C =-3A, I _B =-150mA
*V _{BE(sat)}	-	-	-1.2	V	I _C =-3A, I _B =-150mA
*h _{FE}	120	-	400	-	V _{CE} =-1V, I _C =-1A
*h _{FE}	30	-	-	-	V _{CE} =-1V, I _C =-3A

*Pulse Test : Pulse Width ≤380μs, Duty Cycle≤2%

Classification of hFE 1

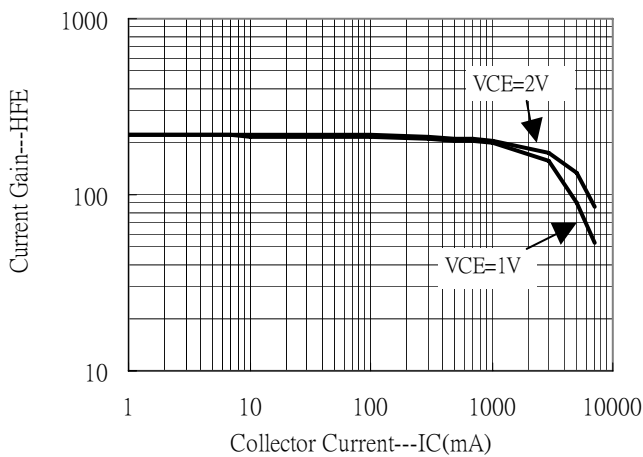
Rank	Y	G
Range	120~240	200~400

Ordering Information

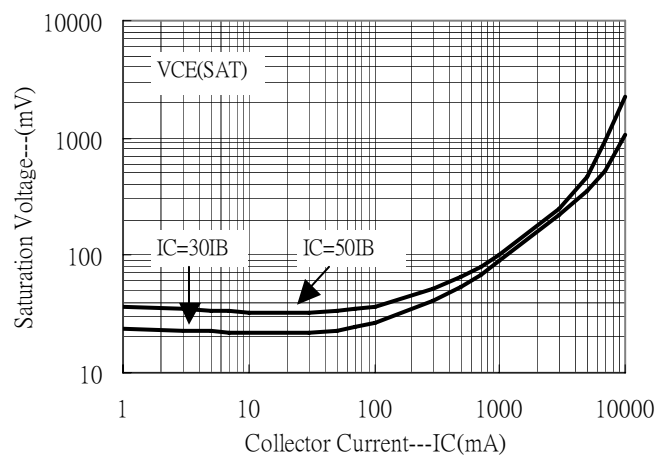
Device	Package	Shipping	Marking
BTA1640I3	TO-251 (RoHS compliant)	80 pcs / tube, 50 tubes / box	A1640

Characteristic Curves

Current Gain vs Collector Current

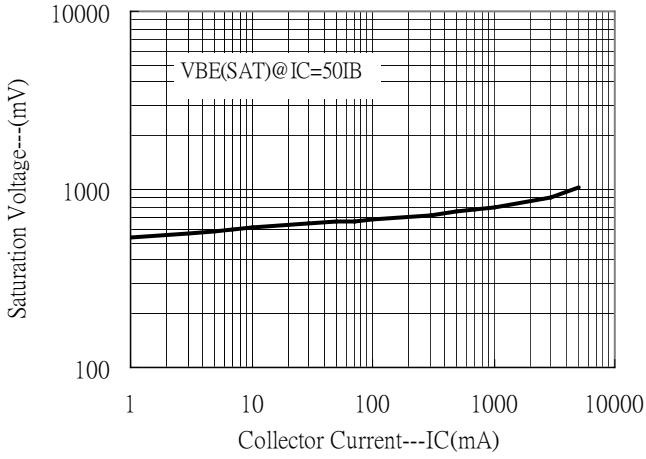


Saturation Voltage vs Collector Current

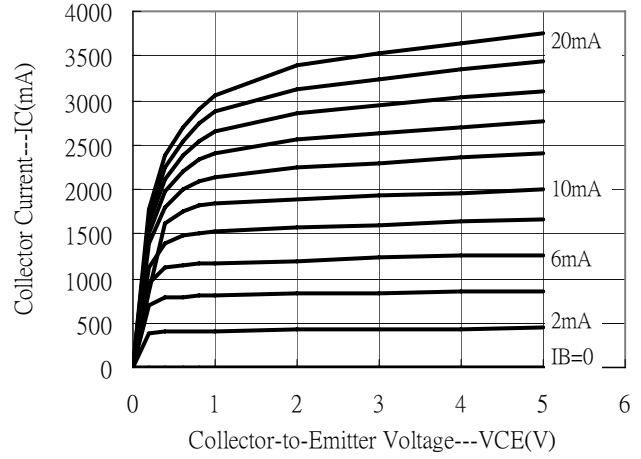


Characteristic Curves(Cont.)

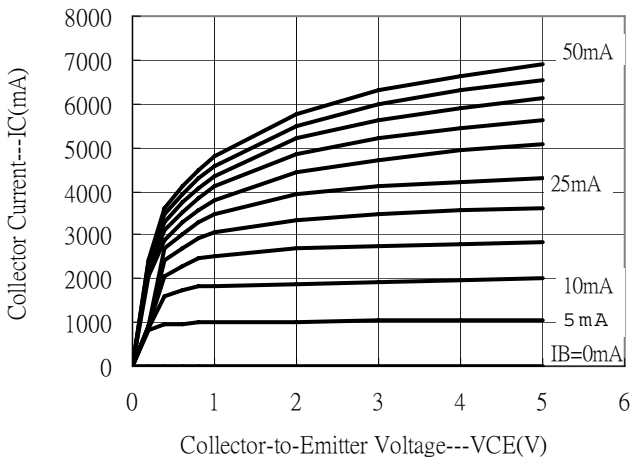
Saturation Voltage vs Collector Current



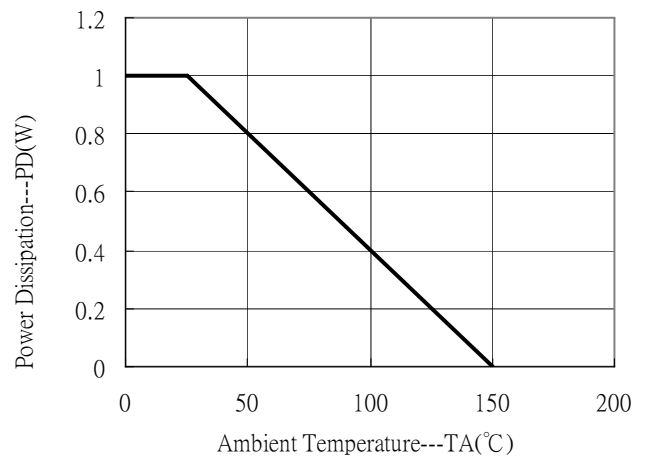
Grounded Emitter Output Characteristics



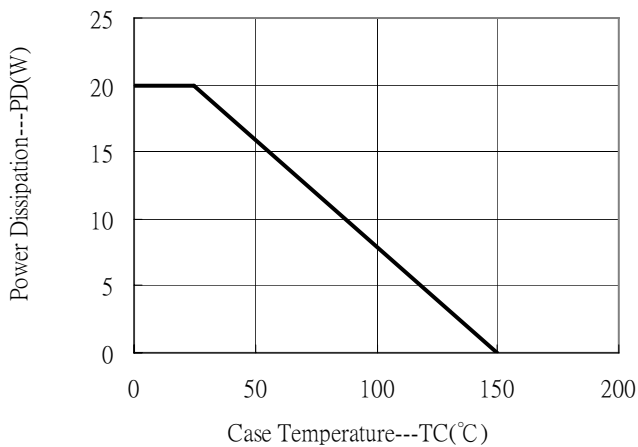
Grounded Emitter Output Characteristics



Power Derating Curve



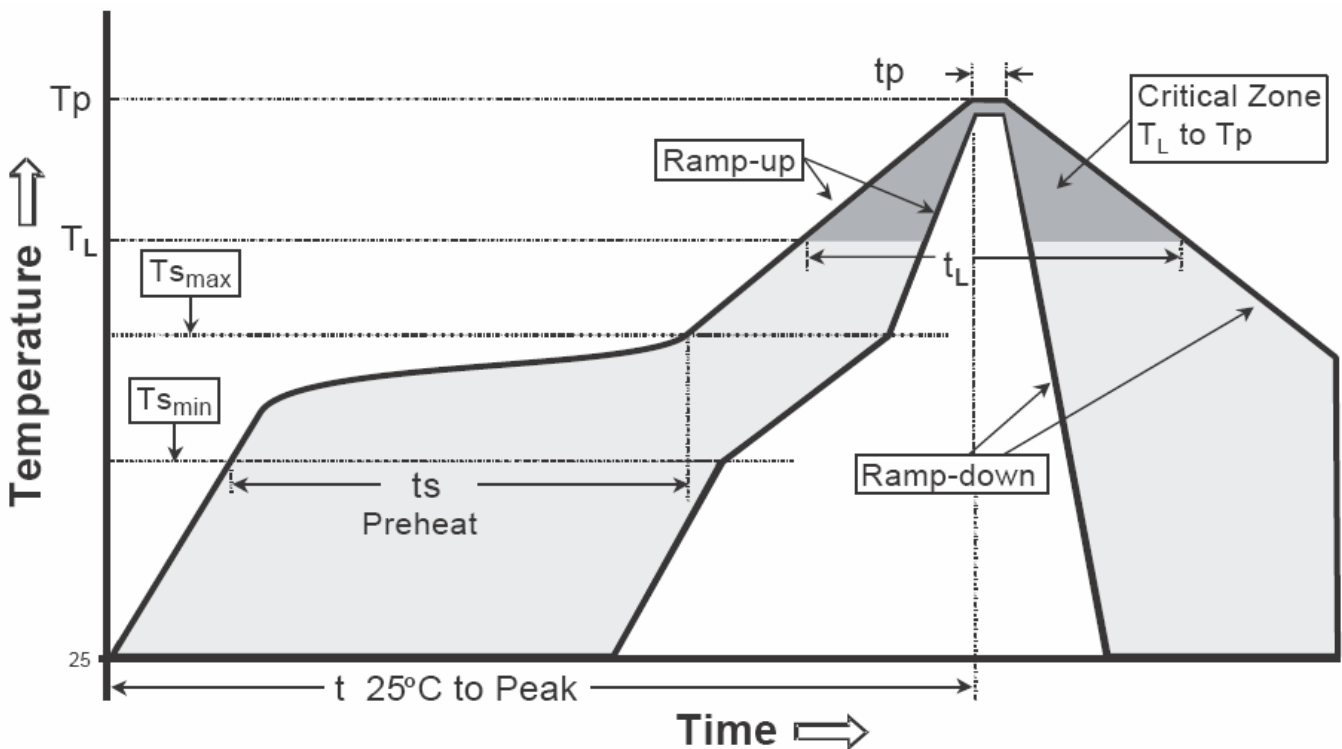
Power Derating Curve



Recommended wave soldering condition

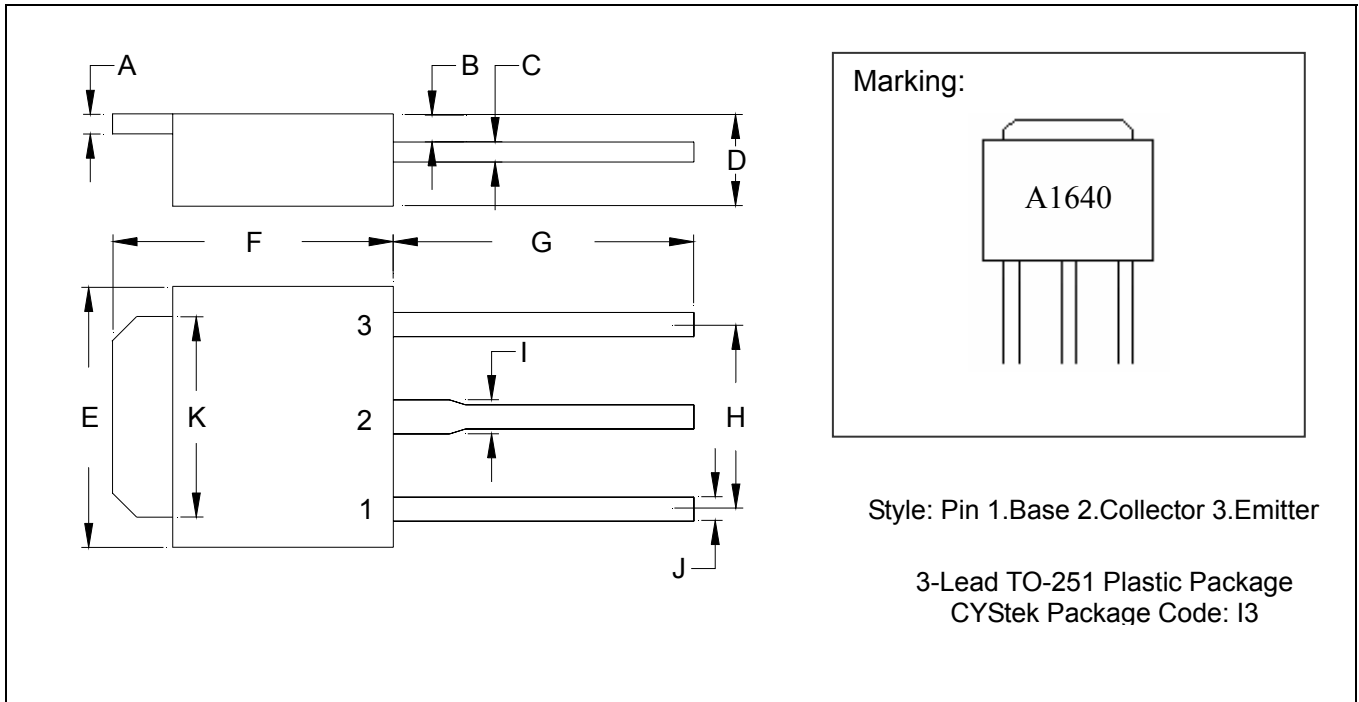
Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (Tl)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(Tp)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

TO-251 Dimension



*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.0177	0.0217	0.45	0.55	G	0.2559	-	6.50	-
B	0.0354	0.0591	0.90	1.50	H	-	*0.1811	-	*4.60
C	0.0177	0.0236	0.45	0.60	I	-	0.0449	-	1.14
D	0.0866	0.0945	2.20	2.40	J	-	0.0346	-	0.88
E	0.2441	0.2677	6.20	6.80	K	0.2047	0.2165	5.20	5.50
F	0.2677	0.2835	6.80	7.20					

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: KFC; pure tin plated
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

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